Search Notes

Application/Control No.
10/537,297
Examiner

Applicant(s)/Patent under Reexamination
QUER ET AL.

Art Unit

Helen C. Kwok

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SEARCHED				
Class	Subclass	Date	Examiner	
73	514.29	3/30/2006	нк	
73	514.16	3/30/2006	нк	
73	514.36	3/30/2006	нк	
73	514.38	3/30/2006	нк	
73	514.01	3/30/2006	нк	
73	514.15	3/30/2006	нк	
73	514.34	3/30/2006	нк	
73	514.35	3/30/2006	нк	
73	504.12	3/30/2006	нк	
73	504.16	3/30/2006	нк	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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